

Search Notes



Application/Control No.

10/784,188

Examiner

John C. Hong

Applicant(s)/Patent under Reexamination

MARUYAMA ET AL.

Art Unit

3726

SEARCHED

Class	Subclass	Date	Examiner
29	592	8/1/85	Sh
	426.3		
	426.1		
	705		
	403.1		
	403.2		
	403.3		
	428		
	429		
	430		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
09/819,892 USPN 6,722,010	8/1/85	Sh
East Search	/	/